

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10567757	OHNO ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Jafar Parsa	1621

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
570	165, 177, 178	3/26/2008	jp

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
STN	3/20/2008	jp
inventor name search	3/26/2008	jp

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>